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November 2013

SGP10N60RUFD 600 V, 10 A Short Circuit Rated IGBT

General Description

Fairchild's RUFD series of Insulated Gate Bipolar Transistors (IGBTs) provide low conduction and switching losses as well as short circuit ruggedness. The RUFD series is designed for applications such as motor control, Uninterrupted Power Supplies (UPS) and general inverters where short circuit ruggedness is a required feature.

Features

- 10 A, 600 V, T_C = 100°C
- Low Saturation Voltage: V_{CE}(sat) = 2.1 V @ I_C = 10 A
- High Speed Switching
- High Input Impedance
- · Short Circuit Rating

Applications

Motor Control, UPS, General Inverter





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Description		Ratings	Unit
V _{CES}	Collector-Emitter Voltage		600	V
V _{GES}	Gate-Emitter Voltage		± 20	V
	Collector Current	@ $T_C = 25^{\circ}C$	16	Α
I _C	Collector Current	@ T _C = 100°C	10	A
I _{CM (1)}	Pulsed Collector Current		30	Α
	Diode Continuous Forward Current	@ T _C = 25°C	24	Α
I _F	Diode Continuous Forward Current	@ T _C = 100°C	12	Α
I _{FM}	Diode Maximum Forward Current		92	Α
T _{SC}	Short Circuit Withstand Time @ T _C = 100°C		10	us
P _D	Maximum Power Dissipation	@ $T_C = 25^{\circ}C$	75	W
	Maximum Power Dissipation	@ T _C = 100°C	30	W
T _J	Operating Junction Temperature		-55 to +150	°C
T _{stg}	Storage Temperature Range		-55 to +150	°C
T _L	Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Second	300	°C	

Notes:
(1) Repetitive rating: Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction-to-Case		1.6	°C/W
$R_{\theta JC}(DIODE)$	Thermal Resistance, Junction-to-Case		2.5	°C/W
R _{a.IA}	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

Electrical Characteristics of the IGBT $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Chai	racteristics					
BV _{CES}	Collector-Emitter Breakdown Voltage	$V_{GE} = 0 \text{ V, I}_{C} = 250 \text{ uA}$	600			V
$\Delta B_{VCES} \over \Delta T_J$	Temperature Coefficient of Breakdown Voltage	V _{GE} = 0 V, I _C = 1 mA		0.6		V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0 V$			250	uA
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0 V$			± 100	nΑ
On Char	racteristics					
$V_{GE(th)}$	G-E Threshold Voltage	$I_C = 10 \text{ mA}, V_{CE} = V_{GE}$	5.0	6.0	8.5	V
	Collector to Emitter	$I_C = 10 \text{ A}, V_{GE} = 15 \text{ V}$		2.2	2.8	V
V _{CE(sat)}	Saturation Voltage	I _C = 16 A, V _{GE} = 15 V		2.5		V
Dynami	c Characteristics					
C _{ies}	Input Capacitance	V - 20 V V - 0 V	/	660		pF
C _{oes}	Output Capacitance	$V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V},$ f = 1 MHz		115		рF
C _{res}	Reverse Transfer Capacitance	1 – 1 1011 12		25		pF
	ng Characteristics			4.5	1 1	
t _{d(on)}	Turn-On Delay Time			15		ns
t _r	Rise Time			30		ns
t _{d(off)}	Turn-Off Delay Time	$V_{CC} = 300 \text{ V}, I_{C} = 10 \text{ A},$		36	50	ns
t _f	Fall Time	$R_G = 20 \Omega$, $V_{GE} = 15 V$,		158	200	ns
Eon	Turn-On Switching Loss	Inductive Load, T _C = 25°C		141		uJ
E _{off}	Turn-Off Switching Loss			215		uJ
E _{ts}	Total Switching Loss			356	500	uJ
t _{d(on)}	Turn-On Delay Time Rise Time			16 33		ns
t _r	Turn-Off Delay Time	V 200 V I 40 A		42	60	ns
t _{d(off)}	Fall Time	$V_{CC} = 300 \text{ V}, I_{C} = 10 \text{ A},$ $R_{G} = 20 \Omega, V_{GE} = 15 \text{ V},$		242	350	ns ns
E _{on}	Turn-On Switching Loss	Inductive Load, $T_C = 125^{\circ}C$		161	330	uJ
E _{off}	Turn-Off Switching Loss			452		uJ
E _{ts}	Total Switching Loss			613	860	uJ
T _{sc}	Short Circuit Withstand Time	V _{CC} = 300 V, V _{GE} = 15 V @ T _C = 100°C	10			us
Q _q	Total Gate Charge		/	30	45	nC
Q _{ge}	Gate-Emitter Charge	$V_{CE} = 300 \text{ V}, I_{C} = 10 \text{ A},$		5	10	nC
Q _{gc}	Gate-Collector Charge	V _{GE} = 15 V		8	16	nC
L _e	Internal Emitter Inductance	Measured 5mm from PKG		7.5		nH

Electrical Characteristics of DIODE $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
V_{FM}	Diode Forward Voltage	I _F = 12 A	$T_C = 25^{\circ}C$		1.4	1.7	V
		IF = 12 A	T _C = 100°C		1.3	V	
t _{rr}	Diode Reverse Recovery Time		$T_C = 25^{\circ}C$		42	60	ne
			T _C = 100°C		60		ns
1	I _{rr} Diode Peak Reverse Recovery Current	тр,	$T_C = 25^{\circ}C$		3.5	6.0	Α
'rr			T _C = 100°C		5.6		^
Q _{rr}	Diode Reverse Recovery Charge		$T_C = 25^{\circ}C$		80	180	nC
			$T_C = 100^{\circ}C$		220		110

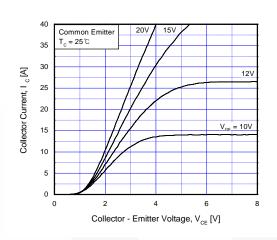


Fig 1. Typical Output Characteristics

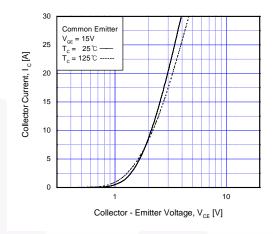


Fig 2. Typical Saturation Voltage Characteristics

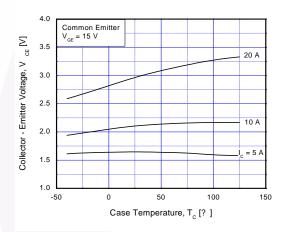


Fig 3. Saturation Voltage vs. Case Temperature at Variant Current Level

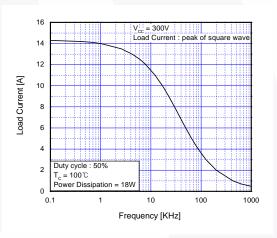


Fig 4. Load Current vs. Frequency

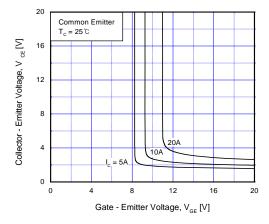


Fig 5. Saturation Voltage vs. V_{GE}

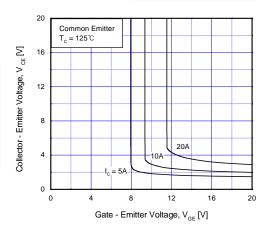


Fig 6. Saturation Voltage vs. V_{GE}

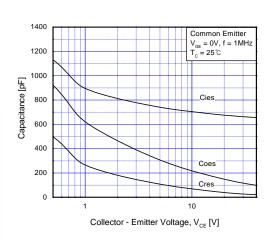


Fig 7. Capacitance Characteristics

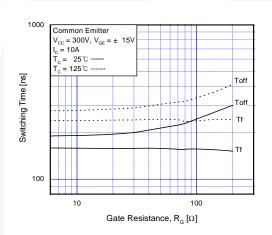


Fig 9. Turn-Off Characteristics vs.
Gate Resistance

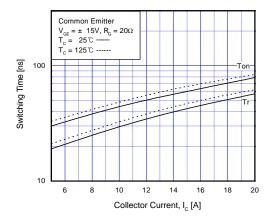


Fig 11. Turn-On Characteristics vs. Collector Current

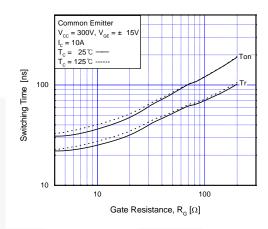


Fig 8. Turn-On Characteristics vs.
Gate Resistance

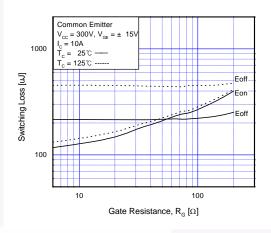


Fig 10. Switching Loss vs. Gate Resistance

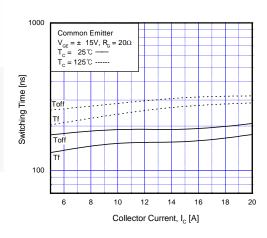


Fig 12. Turn-Off Characteristics vs. Collector Current

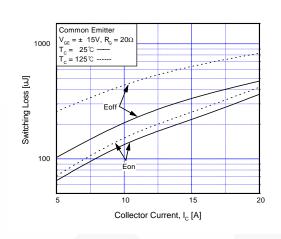


Fig 13. Switching Loss vs. Collector Current

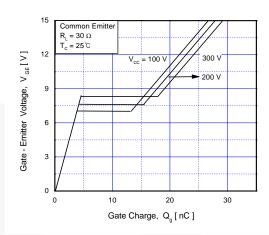


Fig 14. Gate Charge Characteristics

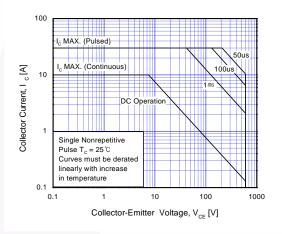


Fig 15. SOA Characteristics

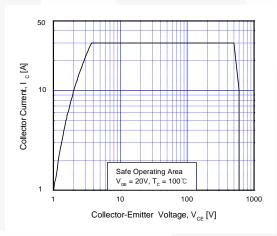


Fig 16. Turn-Off SOA Characteristics

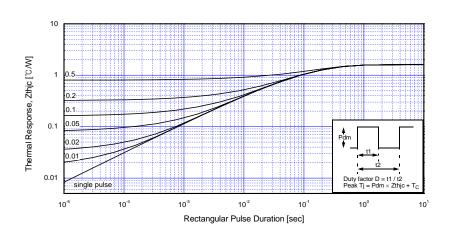


Fig 17. Transient Thermal Impedance of IGBT

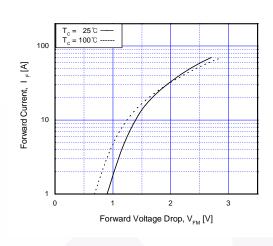


Fig 18. Forward Characteristics

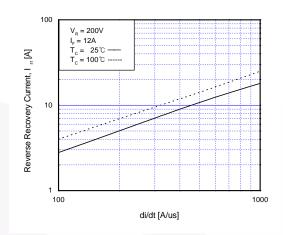


Fig 19. Reverse Recovery Current

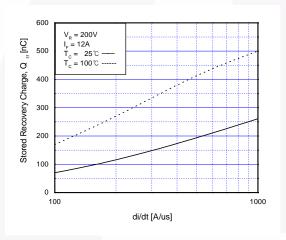


Fig 20. Stored Charge

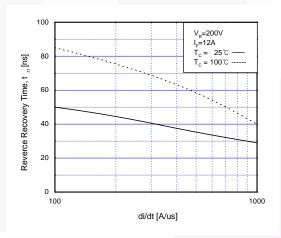


Fig 21. Reverse Recovery Time

Mechanical Dimensions

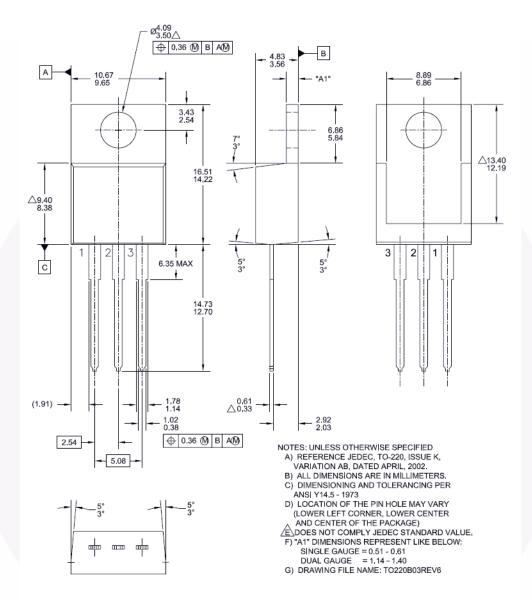


Figure 22. TO-220 3L - TO-220, MOLDED, 3LEAD, JEDEC VARIATION AB

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